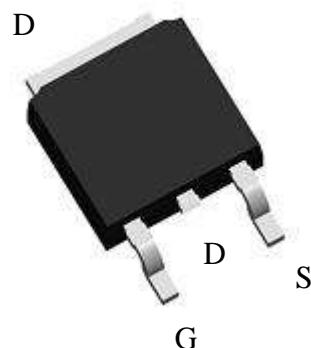


P-Channel Enhancement Mode Power MOSFET

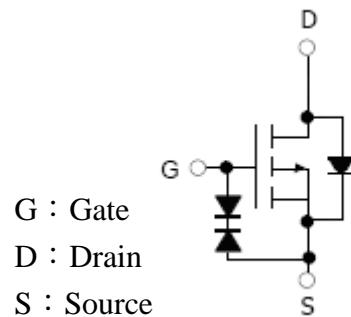
Features:

- Low Gate Charge
- Simple Drive Requirement
- ESD Protected Gate
- Pb-free Lead Plating & Halogen-free Package

TO-252(DPAK)



BVDSS	-60V
ID@VGS=-10V, Tc=25°C	-23.6A
RDS(ON)@VGS=-10V, Id=-6A	23mΩ(typ)
RDS(ON)@VGS=-4.5V, Id=-4A	37mΩ(typ)
RDS(ON)@VGS=-4V, Id=-3A	44mΩ(typ)



Ordering Information

Device	Package	Shipping
KJB30P06K	TO-252 (Pb-free lead plating & halogen-free package)	2500 pcs / Tape & Reel



Absolute Maximum Ratings ($T_C=25^\circ C$, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V_{DS}	-60	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current @ $T_J=175^\circ C$, $T_C=25^\circ C$, $V_{GS}=-10V$ (Note 1)	I_D	-23.6	A
Continuous Drain Current @ $T_J=175^\circ C$, $T_C=100^\circ C$, $V_{GS}=-10V$ (Note 1)		-16.7	
Continuous Drain Current @ $T_A=25^\circ C$, $V_{GS}=-10V$ (Note 2)	I_{DSM}	-6.7	A
Continuous Drain Current @ $T_A=70^\circ C$, $V_{GS}=-10V$ (Note 2)		-5.4	
Pulsed Drain Current (Note 3)	I_{DM}	-94	
Avalanche Current (Note 3)	I_{AS}	-23.6	
Avalanche Energy @ $L=0.5mH$, $I_D=-23.6A$, $V_{DD}=-30V$ (Note 2)	E_{AS}	139	mJ
Total Power Dissipation	P_D	42	W
		21	
	P_{DSM}	2.5	
		1.6	
Operating Junction and Storage Temperature Range	T_J , T_{Stg}	-55~+175	°C

* 100% UIS testing in condition of $V_D=-15V$, $L=0.5mH$, $V_G=10V$, $I_{AS}=-12A$, Rated $V_{DS}=-60V$

Thermal Data

Parameter	Symbol	Typical	Maximum	Unit
Thermal Resistance, Junction-to-case	$R_{\theta JC}$	2.7	3.6	°C/W
Thermal Resistance, Junction-to-ambient, $t \leq 10s$ (Note 2)	$R_{\theta JA}$	15	18	
Thermal Resistance, Junction-to-ambient, steady state		40	50	

- Note : 1.The power dissipation P_D is based on $T_{J(MAX)}=175^\circ C$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
 2. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^\circ C$. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
 3. Pulse width limited by junction temperature $T_{J(MAX)}=175^\circ C$. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^\circ C$.

Characteristics (T_c=25°C, unless otherwise specified)

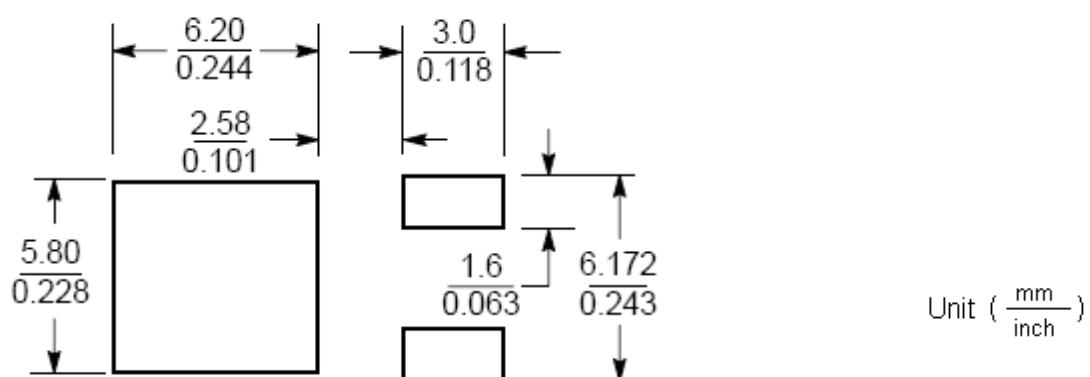
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-60	-	-	V	V _{GS} =0V, I _D =-250μA
V _{GS(th)}	-1.5	-	-2.5		V _{DS} =V _{GS} , I _D =-250μA
I _{GSS}	-	-	±10	μA	V _{GS} =±16V, V _{DS} =0V
I _{DSS}	-	-	-1		V _{DS} =-60V, V _{GS} =0V
	-	-	-25		V _{DS} =-48V, V _{GS} =0V, T _J =125°C
R _{D(on)} *1	-	23	30	mΩ	V _{GS} =-10V, I _D =-6A
	-	37	48		V _{GS} =-4.5V, I _D =-4A
	-	44	57		V _{GS} =-4V, I _D =-3A
G _{FS} *1	-	15	-	S	V _{DS} =-5V, I _D =-6A
Dynamic					
Q _g *1, 2	-	31.9	47.9	nC	I _D =-23A, V _{DS} =-48V, V _{GS} =-10V
Q _{gs} *1, 2	-	4.4	-		
Q _{gd} *1, 2	-	13	-	ns	V _{DS} =-30V, I _D =-1A, V _{GS} =-10V, R _G =3.3Ω
t _{d(ON)} *1, 2	-	14.2	21.3		
t _r *1, 2	-	19	28.5		
t _{d(OFF)} *1, 2	-	55.4	83.1		
t _f *1, 2	-	34.6	51.9	pF	V _{GS} =0V, V _{DS} =-25V, f=1MHz
C _{iss}	-	1430	-		
C _{oss}	-	206	-		
C _{rss}	-	121	-	Ω	f=1MHz
R _g	-	4	-		
Source-Drain Diode Ratings and Characteristics					
I _S *1	-	-	-23.6	A	
I _{SM} *1	-	-	-94		
V _{SD} *1	-	-0.78	-1.2	V	I _S =-6A, V _{GS} =0V
t _{rr}	-	11	16.5	ns	I _F =-23A, dI _F /dt=100A/μs
Q _{rr}	-	5	-	nC	

Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

*2.Independent of operating temperature

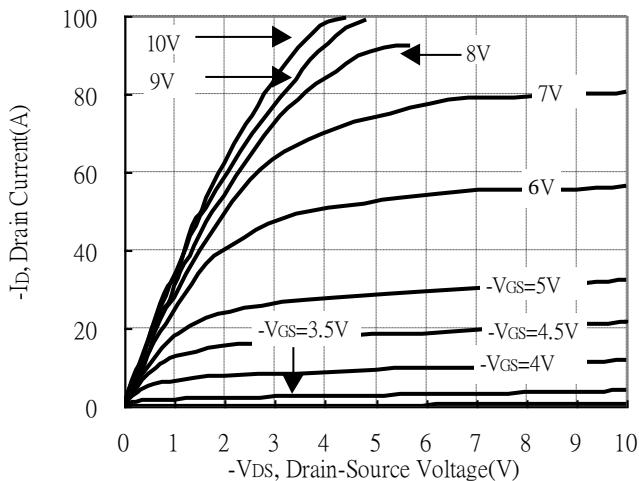
*3.Pulse width limited by maximum junction temperature.

Recommended soldering footprint

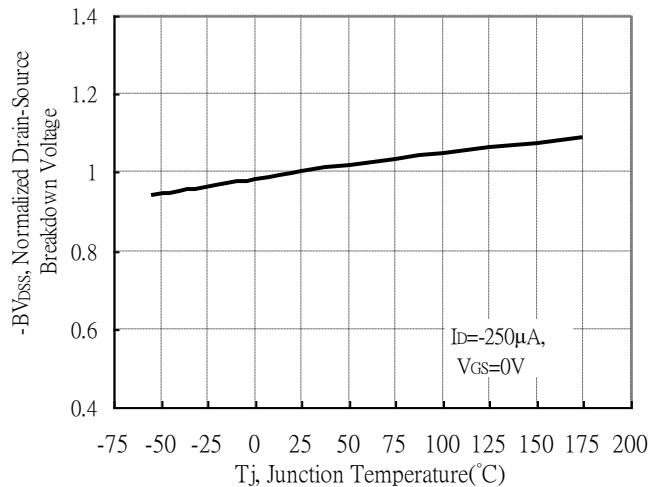


Typical Characteristics

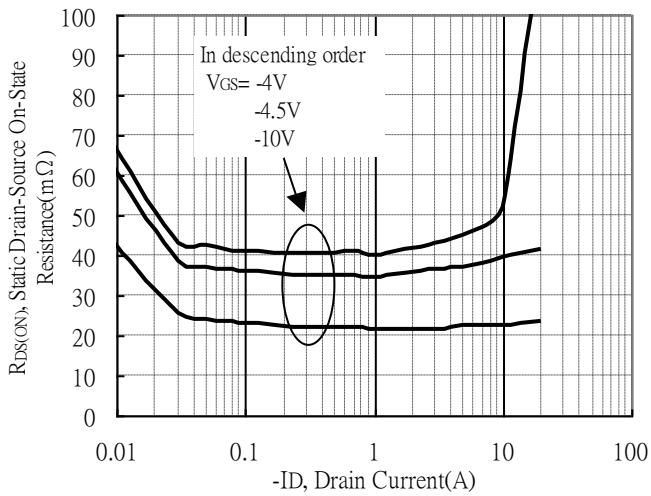
Typical Output Characteristics



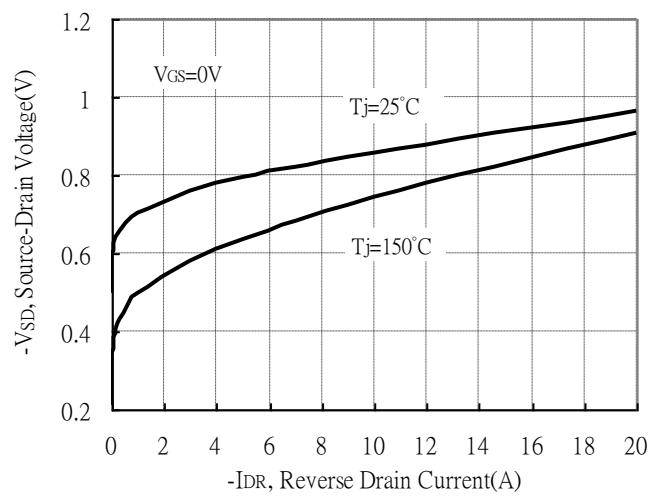
Breakdown Voltage vs Ambient Temperature



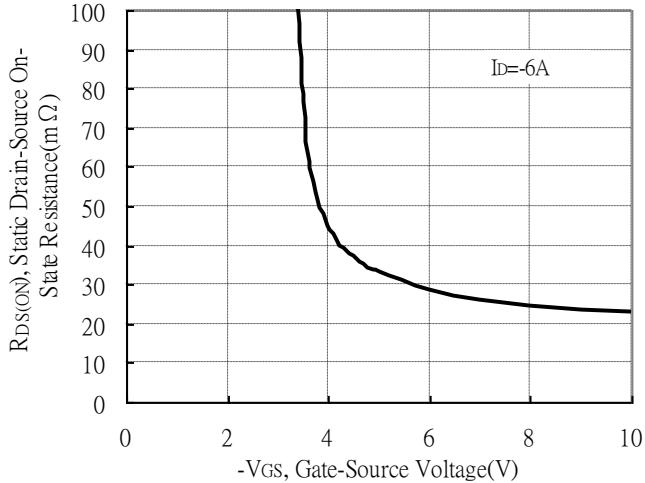
Static Drain-Source On-State resistance vs Drain Current



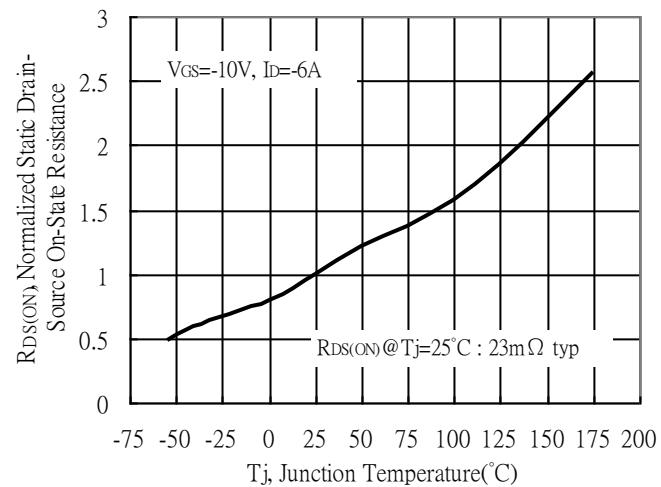
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

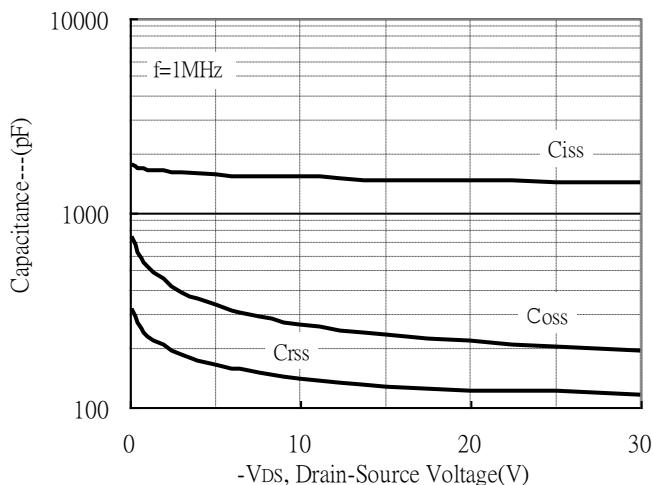


Drain-Source On-State Resistance vs Junction Temperature

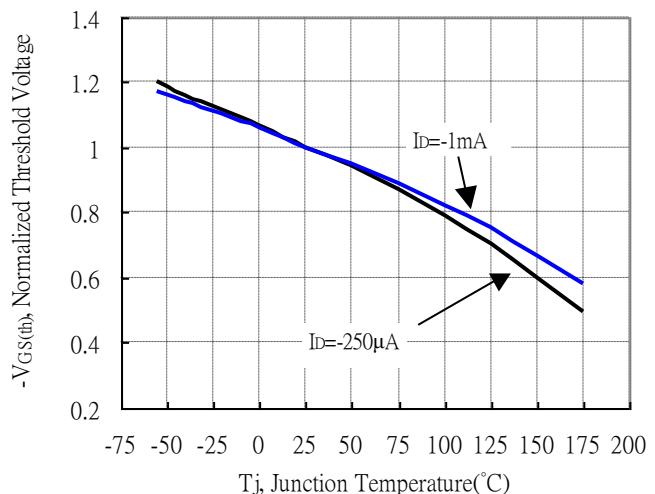


Typical Characteristics (Cont.)

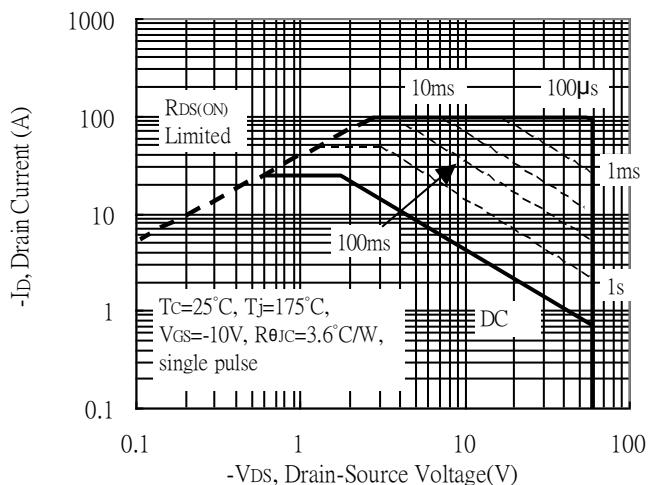
Capacitance vs Drain-to-Source Voltage



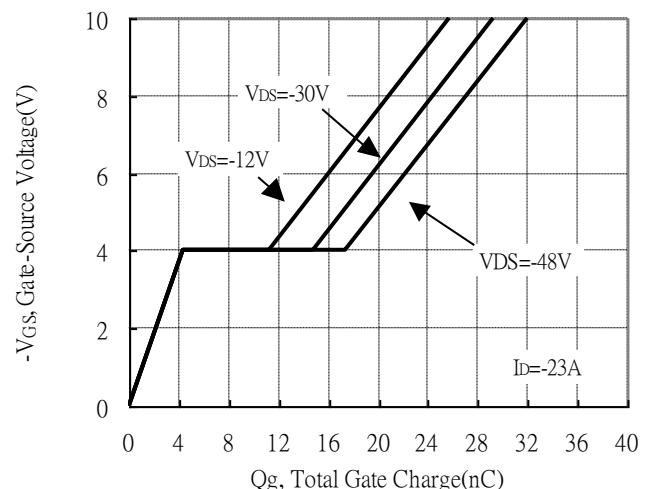
Threshold Voltage vs Junction Temperature



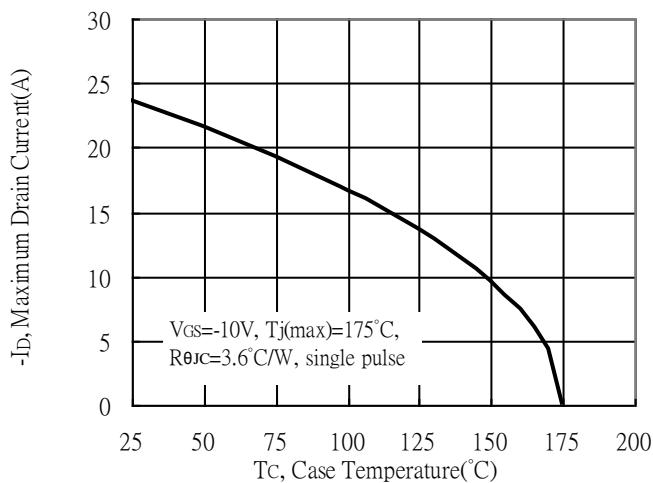
Maximum Safe Operating Area



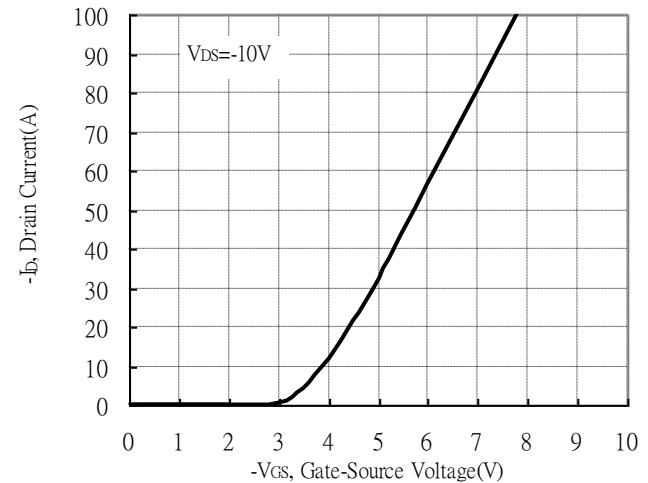
Gate Charge Characteristics



Maximum Drain Current vs Case Temperature

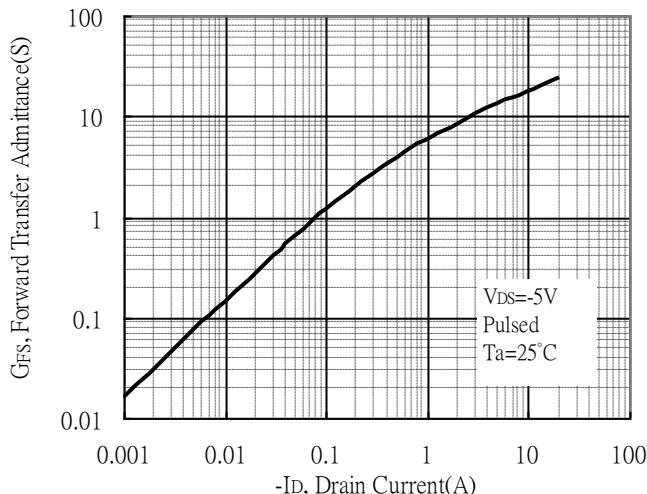


Typical Transfer Characteristics

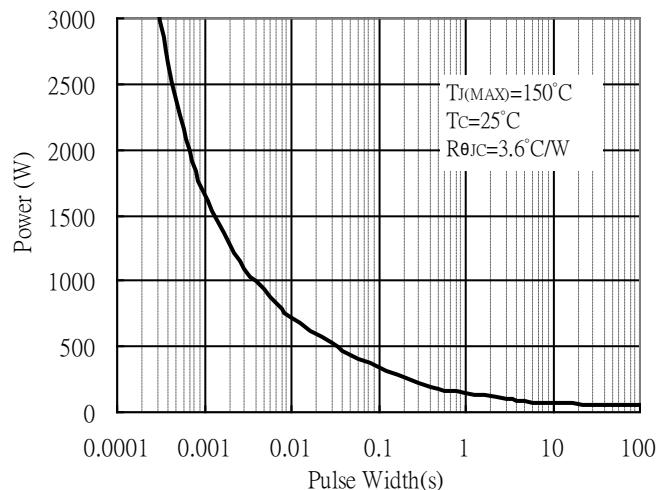


Typical Characteristics (Cont.)

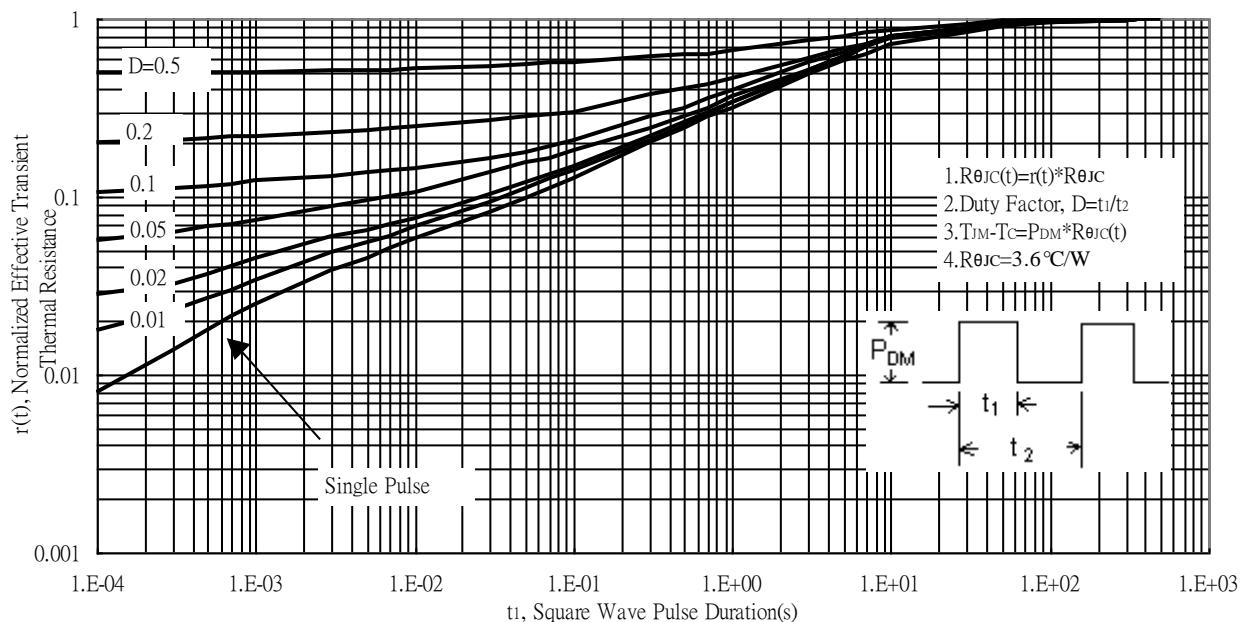
Forward Transfer Admittance vs Drain Current



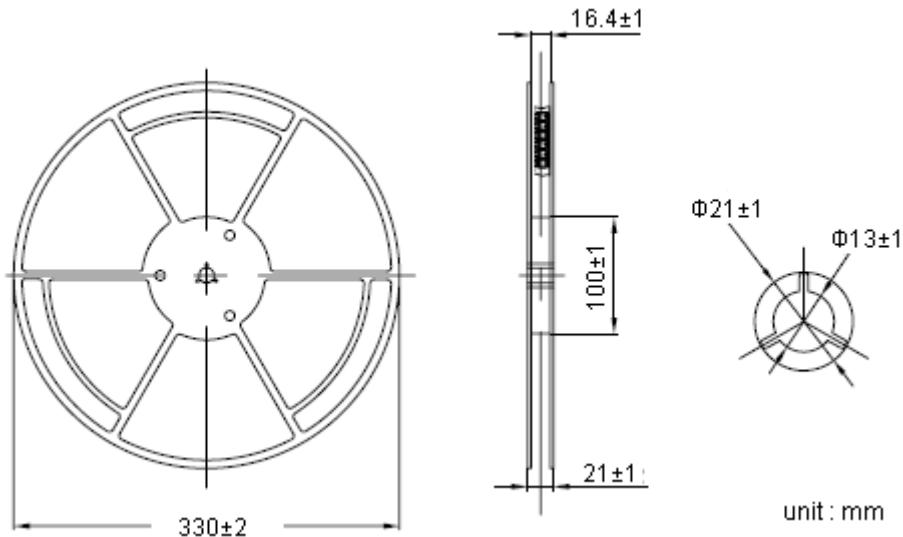
Single Pulse Power Rating, Junction to Case



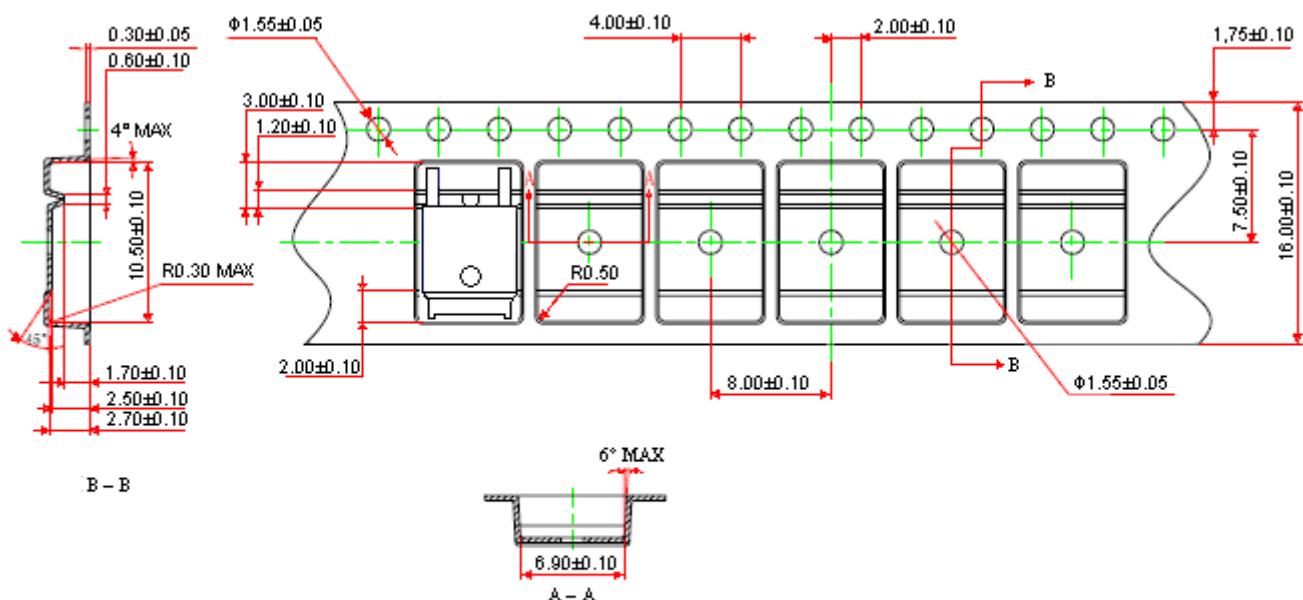
Transient Thermal Response Curves



Reel Dimension



Carrier Tape Dimension

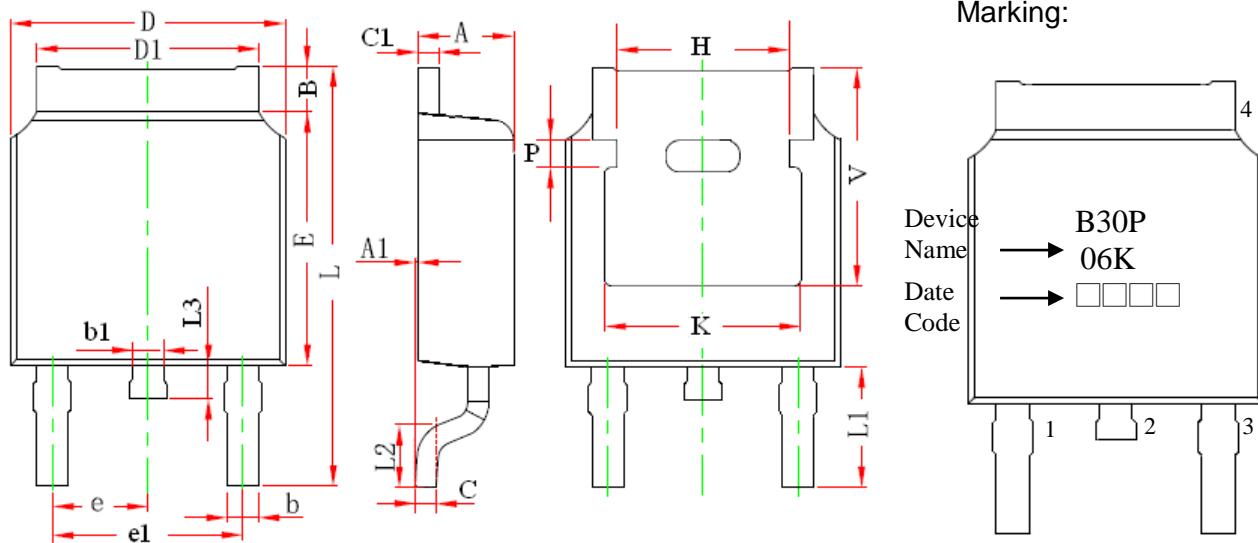


Notes:

1. 10 sprocket hole pitch cumulative tolerance ±0.2.
2. Camber not to exceed 1mm in 100mm.
3. Material: conductive black polystyrene, antistatic coated : $10^5 \Omega/\square \sim 10^{11} \Omega/\square$

unit : mm

TO-252 Dimension



3-Lead TO-252 Plastic Surface Mount Package

Style: Pin 1.Gate 2.Drain 3.Source
4.Drain

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.087	0.094	2.200	2.400	e	0.086	0.094	2.186	2.386
A1	0.000	0.005	0.000	0.127	e1	0.172	0.188	4.372	4.772
B	0.039	0.048	0.990	1.210	H	0.163	REF	4.140	REF
b	0.026	0.034	0.660	0.860	K	0.190	REF	4.830	REF
b1	0.026	0.034	0.660	0.860	L	0.386	0.409	9.800	10.400
C	0.018	0.023	0.460	0.580	L1	0.114	REF	2.900	REF
C1	0.018	0.023	0.460	0.580	L2	0.055	0.067	1.400	1.700
D	0.256	0.264	6.500	6.700	L3	0.024	0.039	0.600	1.000
D1	0.201	0.215	5.100	5.460	P	0.026	REF	0.650	REF
E	0.236	0.244	6.000	6.200	V	0.211	REF	5.350	REF